

# FCC Test Report

**Client Name** : Beijing Silion Technology Corp.,LTD.

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**Client Address** : 5 Floor, Building A, No.3 Longyu North St.,  
Changping District, Beijing, 102200, China

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**Product Name** : RFID module

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**Report Date** : Mar. 17, 2023

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**Shenzhen Anbotek Compliance Laboratory Limited**



**Shenzhen Anbotek Compliance Laboratory Limited**

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# Contents

1. General Information .....	6
1.1. Client Information .....	6
1.2. Description of Device (EUT) .....	6
1.3. Auxiliary Equipment Used During Test .....	7
1.4. Description of Test Modes .....	7
1.5. Description Of Test Setup .....	8
1.6. Test Equipment List .....	9
1.7. Measurement Uncertainty .....	10
1.8. Description of Test Facility .....	10
2. Summary of Test Results .....	11
3. Conducted Emission Test .....	12
3.1. Test Standard and Limit .....	12
3.2. Test Setup .....	12
3.3. Test Procedure .....	12
3.4. Test Data .....	12
4. Radiation Spurious Emission and Band Edge .....	15
4.1. Test Standard and Limit .....	15
4.2. Test Setup .....	15
4.3. Test Procedure .....	16
4.4. Test Data .....	17
5. Maximum Peak Output Power Test .....	22
5.1. Test Standard and Limit .....	22
5.2. Test Setup .....	22
5.3. Test Procedure .....	22
5.4. Test Data .....	22
6. 20DB Occupy Bandwidth Test .....	24
6.1. Test Standard .....	24
6.2. Test Setup .....	24
6.3. Test Procedure .....	24
6.4. Test Data .....	24
7. Carrier Frequency Separation Test .....	26
7.1. Test Standard and Limit .....	26
7.2. Test Setup .....	26
7.3. Test Procedure .....	26
7.4. 7.4. Test Data .....	26
8. Number of Hopping Channel Test .....	28
8.1. Test Standard and Limit .....	28



8.2. Test Setup .....	28
8.3. Test Procedure .....	28
8.4. Test Data .....	28
9. Dwell Time Test .....	30
9.1. Test Standard and Limit .....	30
9.2. Test Setup .....	30
9.3. Test Procedure .....	30
9.4. Test Data .....	30
10. 100kHz Bandwidth of Frequency Band Edge Requirement .....	32
10.1. Test Standard and Limit .....	32
10.2. Test Setup .....	32
10.3. Test Procedure .....	32
10.4. Test Data .....	32
11. Antenna Requirement .....	35
11.1. Test Standard and Requirement .....	35
11.2. Antenna Connected Construction .....	35
APPENDIX I -- TEST SETUP PHOTOGRAPH .....	36
APPENDIX II -- EXTERNAL PHOTOGRAPH .....	36
APPENDIX III -- INTERNAL PHOTOGRAPH .....	36



# TEST REPORT

Applicant : Beijing Silion Technology Corp.,LTD.  
Manufacturer : Beijing Silion Technology Corp.,LTD.  
Product Name : RFID module  
Model No. : SIM7500, SIM3500, SIM5500  
Trade Mark : N.A.  
Rating(s) : Input: 5V $\overline{\text{---}}$  3A

**Test Standard(s) : FCC Part15 Subpart C, Section 15.247**

**Test Method(s) : ANSI C63.10: 2020**

The device described above is tested by Shenzhen Anbotek Compliance Laboratory Limited to determine the maximum emission levels emanating from the device and the severe levels of the device can endure and its performance criterion. The measurement results are contained in this test report and Shenzhen Anbotek Compliance Laboratory Limited is assumed full of responsibility for the accuracy and completeness of these measurements. Also, this report shows that the EUT (Equipment Under Test) is technically compliant with the FCC Part 15 Subpart C requirements.

This report applies to above tested sample only and shall not be reproduced in part without written approval of Shenzhen Anbotek Compliance Laboratory Limited.

Date of receipt

Feb. 27, 2023

Date of Test

Feb. 27~Mar. 10, 2023

Prepared by

*Tu Tu Hong*

(TuTu Hong)

Approved & Authorized Signer

*Kingkong Jin*

(Kingkong Jin)



**Revision History**

Report Version	Description	Issued Date
R00	Original Issue.	Mar. 17, 2023



## 1. General Information

### 1.1. Client Information

Applicant	:	Beijing Silion Technology Corp.,LTD.
Address	:	5 Floor, Building A, No.3 Longyu North St., Changping District, Beijing, 102200, China
Manufacturer	:	Beijing Silion Technology Corp.,LTD.
Address	:	5 Floor, Building A, No.3 Longyu North St., Changping District, Beijing, 102200, China
Factory	:	Beijing Silion Technology Corp.,LTD.
Address	:	5 Floor, Building A, No.3 Longyu North St., Changping District, Beijing, 102200, China

### 1.2. Description of Device (EUT)

Product Name	:	RFID module
Model No.	:	SIM7500, SIM3500, SIM5500 (Note: All samples are the same except the model number, appearance and size, so we prepare "SIM7500" for test only.)
Trade Mark	:	N.A.
Test Power Supply	:	DC 5V from Debug board input AC 120V, 60Hz for Adapter
Test Sample No.	:	1-2-1(Normal Sample), 1-2-2(Engineering Sample)
Adapter	:	N.A.
<b>RF Specification</b>		
Support Technology	:	<input checked="" type="checkbox"/> LoRa
Operation Mode	:	<input type="checkbox"/> DSSS <input checked="" type="checkbox"/> FHSS
Support Bandwidth	:	<input checked="" type="checkbox"/> 125KHz <input type="checkbox"/> 250KHz <input type="checkbox"/> 500KHz
Operation Frequency	:	902.75~927.25MHz
Number of Channel	:	50 Channels
Modulation Type	:	ASK
Antenna Type	:	Ceramic antenna
Antenna Gain(Peak)	:	2.5 dBi(Provided by customer)
<b>Remark:</b> 1) For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.		



### 1.3. Auxiliary Equipment Used During Test

Description	Rating(s)
Adapter	Model: PG120D3000G Input: 100-240V~50/60Hz, 1.2A Output: 12.0V=3.0A 36.0W
MacBook Air	Model: A1466 Input: 14.85V/3.05A CMIIT ID:C02HXB48DRVC

### 1.4. Description of Test Modes

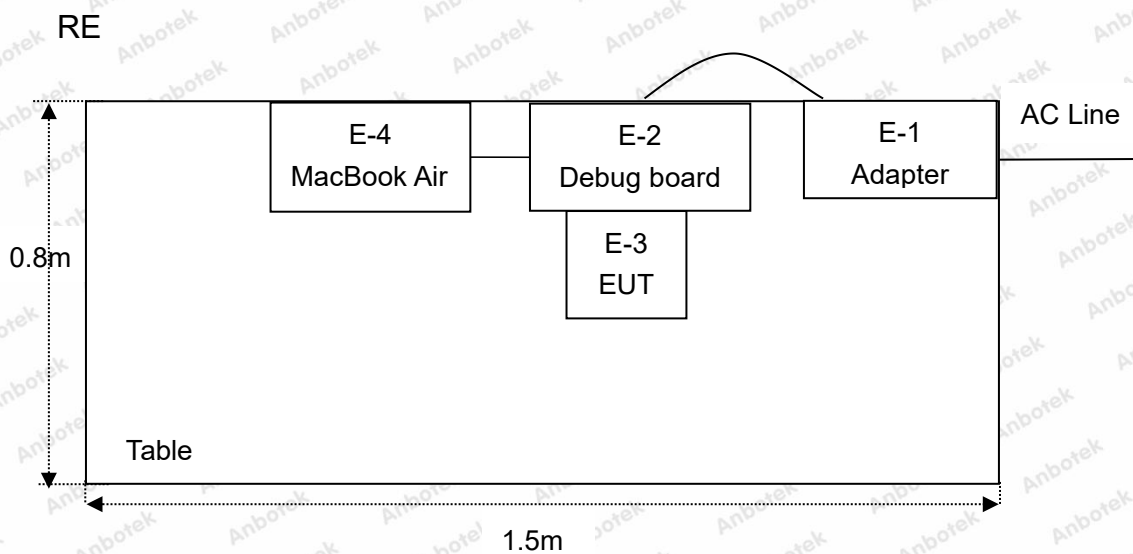
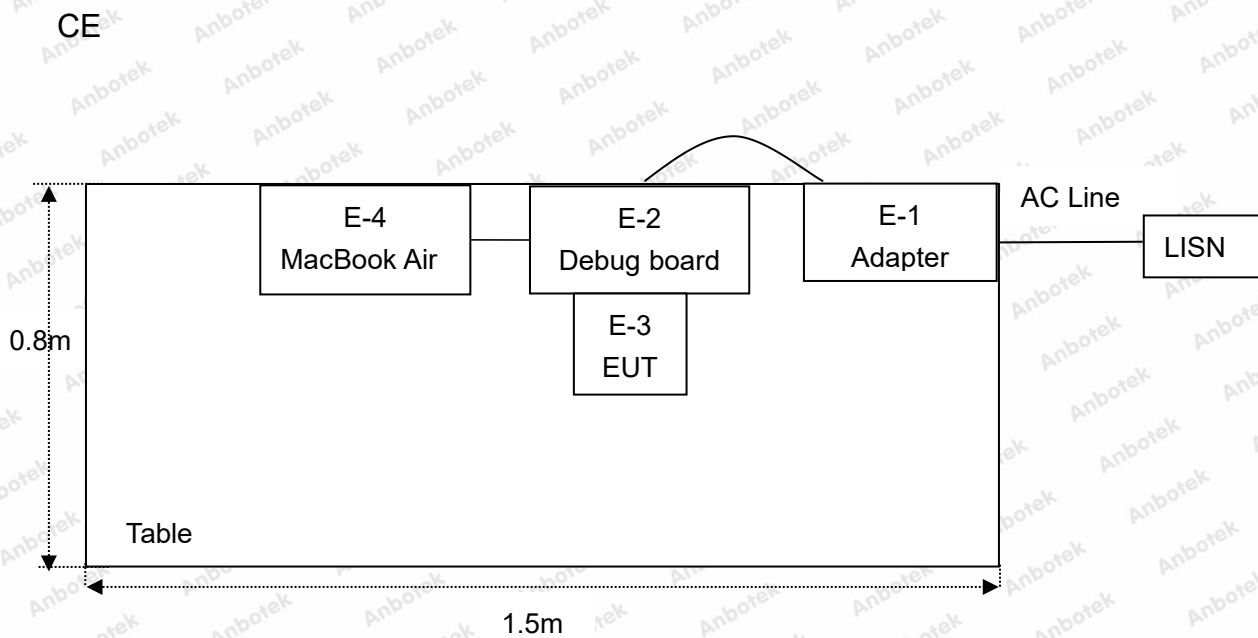
Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)	Channel	Freq. (MHz)
01	902.75	02	903.25	03	903.75	04	904.25	05	904.75
06	905.25	07	905.75	08	906.25	09	906.75	10	907.25
11	907.75	12	908.25	13	908.75	14	909.25	15	909.75
16	910.25	17	910.75	18	911.25	19	911.75	20	912.25
21	912.75	22	913.25	23	913.75	24	914.25	25	914.75
26	915.25	27	915.75	28	916.25	29	916.75	30	917.25
31	917.75	32	918.25	33	918.75	34	919.25	35	919.75
36	920.25	37	920.75	38	921.25	39	921.75	40	922.25
41	922.75	42	923.25	43	923.75	44	924.25	45	924.75
46	925.25	47	925.75	48	926.25	49	926.75	50	927.25

Note:

1. The engineering test program was provided and the EUT was programmed to be in continuously transmitting mode.
2. EUT was tested with Channel 1, 25 and 50.



## 1.5. Description Of Test Setup





### 1.6. Test Equipment List

Item	Equipment	Manufacturer	Model No.	Serial No.	Last Cal.	Cal. Interval
1.	L.I.S.N. Artificial Mains Network	Rohde & Schwarz	ENV216	100055	Oct. 23, 2022	1 Year
2.	Three Phase V-type Artificial Power Network	CYBERTEK	EM5040DT	E215040DT001	Jul. 05, 2022	1 Year
3.	EMI Test Receiver	Rohde & Schwarz	ESCI	100627	Oct. 13, 2022	1 Year
4.	EMI Test Receiver	Rohde & Schwarz	ESR26	101481	Oct. 23, 2022	1 Year
5.	RF Switching Unit	Compliance Direction	RSU-M2	38303	Oct. 22, 2022	1 Year
6.	MXA Spectrum Analysis	Agilent	N9020A	MY51170037	Oct. 13, 2022	1 Year
7.	EMI Preamplifier	SKET Electronic	LNPA-0118G-45	SKET-PA-002	Oct. 13, 2022	1 Year
8.	Double Ridged Horn Antenna	SCHWARZBECK	BBHA 9120D	02555	Oct. 16, 2022	3 Year
9.	Bilog Broadband Antenna	Schwarzbeck	VULB9163	VULB 9163-289	Oct. 23, 2022	1 Year
10.	Loop Antenna	Schwarzbeck	FMZB1519B	00053	Oct. 23, 2022	1 Year
11.	Horn Antenna	A-INFO	LB-180400-KF	J211060628	Oct. 23, 2022	1 Year
12.	Pre-amplifier	SONOMA	310N	186860	Oct. 23, 2022	1 Year
13.	EMI Test Software EZ-EMC	SHURPLE	N/A	N/A	N/A	N/A
14.	MXA Spectrum Analysis	KEYSIGHT	N9020A	MY53280032	Oct. 13, 2022	1 Year
15.	MXG RF Vector Signal Generator	Agilent	N5182A	MY48180656	Oct. 13, 2022	1 Year
16.	Signal Generator	Agilent	E4421B	MY41000743	Oct. 13, 2022	1 Year
17.	DC Power Supply	IVYTECH	IV3605	1804D360510	Oct. 22, 2022	1 Year
18.	Constant Temperature Humidity Chamber	ZHONGJIAN	ZJ-KHWS80B	N/A	Nov. 01, 2021	1 Year



### 1.7. Measurement Uncertainty

Radiation Uncertainty	:	Ur = 3.9 dB (Horizontal)
	:	Ur = 3.8 dB (Vertical)
Conduction Uncertainty	:	Uc = 3.4 dB

### 1.8. Description of Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

#### FCC-Registration No.: 184111

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration No. 184111.

#### ISED-Registration No.: 8058A

Shenzhen Anbotek Compliance Laboratory Limited, EMC Laboratory has been registered and fully described in a report filed with the (ISED) Innovation, Science and Economic Development Canada. The acceptance letter from the ISED is maintained in our files. Registration 8058A.

#### Test Location

Shenzhen Anbotek Compliance Laboratory Limited.

1/F, Building D, Sogood Science and Technology Park, Sanwei community, Hangcheng Street, Bao'an District, Shenzhen, Guangdong, China.518102



## 2. Summary of Test Results

Standard Section	Test Item	Result
15.203/15.247(c)	Antenna Requirement	PASS
15.207	Conducted Emission	PASS
15.205/15.209	Spurious Emission	PASS
15.247(b)(2)	Conducted Peak Output Power	PASS
15.247(a)(1)(i)	20dB Occupied Bandwidth	PASS
15.247(a)(1)	Carrier Frequencies Separation	PASS
15.247(a)(1)(i)	Hopping Channel Number	PASS
15.247(a)(1)(i), 15.247(f)	Dwell Time	PASS
15.247(d)	Band Edge	PASS
<b>Remark:</b> "N/A" is an abbreviation for Not Applicable.		



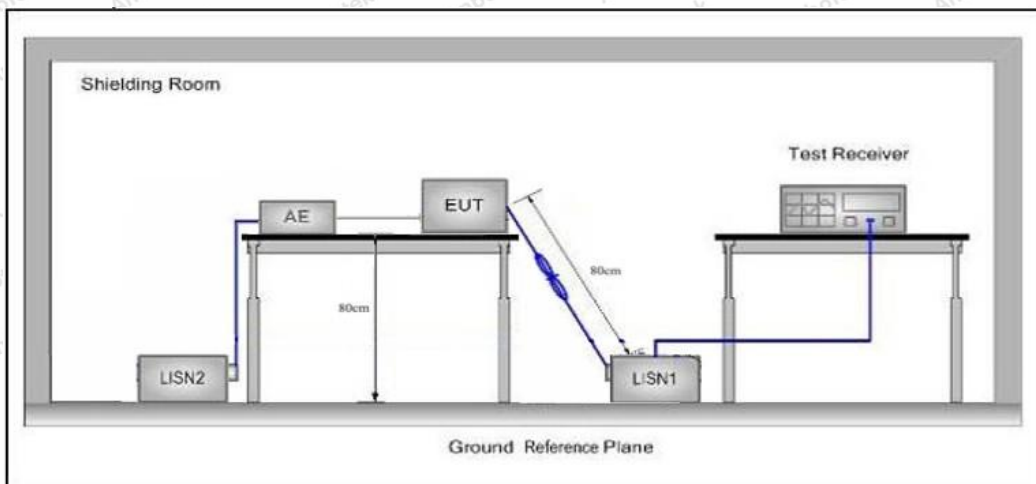
## 3. Conducted Emission Test

### 3.1. Test Standard and Limit

Test Standard	FCC Part15 Section 15.207		
	Frequency	Maximum RF Line Voltage (dBuV)	
		Quasi-peak Level	Average Level
Test Limit	150kHz~500kHz	66 ~ 56 *	56 ~ 46 *
	500kHz~5MHz	56	46
	5MHz~30MHz	60	50

**Remark:** (1) \*Decreasing linearly with logarithm of the frequency.  
 (2) The lower limit shall apply at the transition frequency.

### 3.2. Test Setup



### 3.3. Test Procedure

The EUT system is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC line are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to FCC ANSI C63.10: 2020 on Conducted Emission Measurement.

The bandwidth of test receiver (ESCI) set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

### 3.4. Test Data

During the test, pre-scan all modes, only the worst case is recorded in the report.

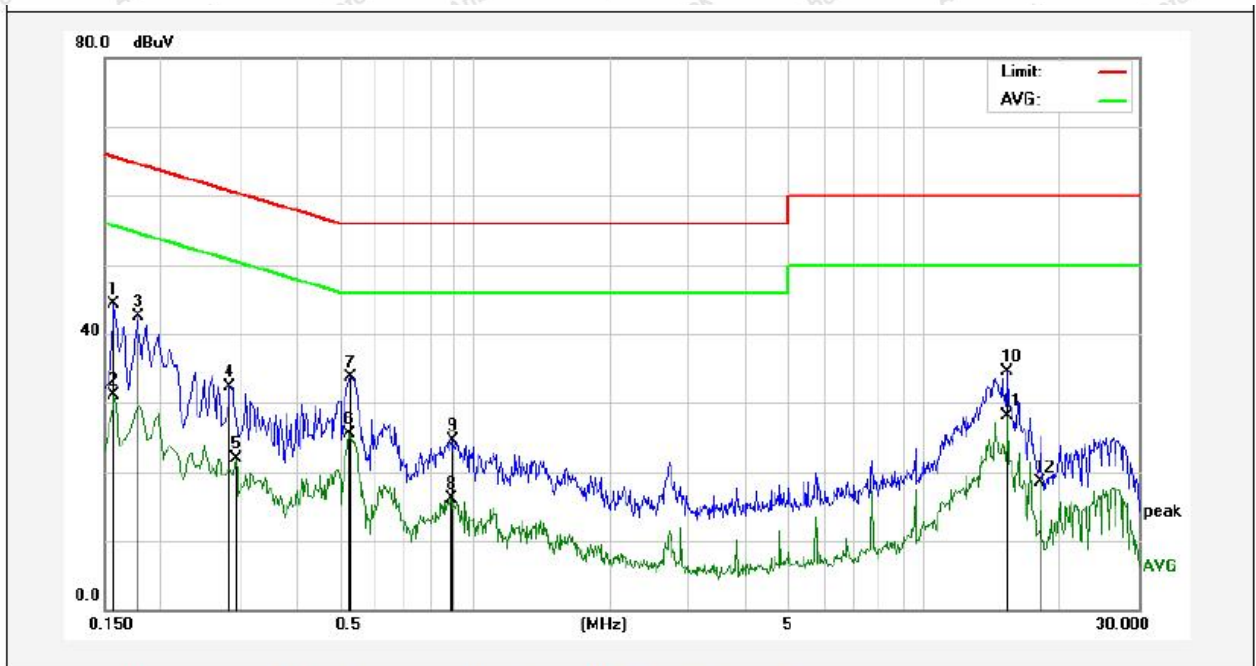
AC conducted emission pre-test at both at AC 120V/60Hz and AC 240V/60Hz modes, recorded worst case AC 120V/60Hz.

Please to see the following pages.



### Conducted Emission Test Data

Test Site: 1# Shielded Room  
 Operating Condition: High CH (927.25MHz)  
 Test Specification: DC 5V from Debug board input AC 120V, 60Hz for Adapter  
 Comment: Live Line  
 Temp.(°C)/Hum.(%RH): 23.9°C/45%RH

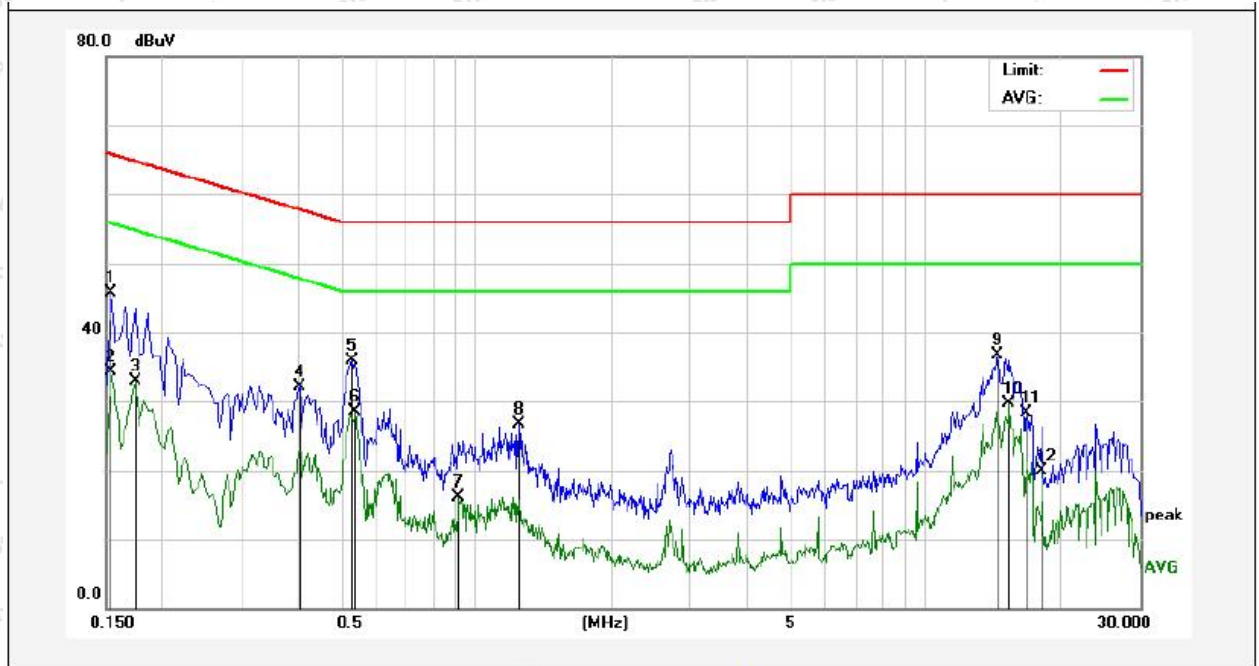


No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.1580	34.63	9.70	44.33	65.56	-21.23	QP	
2	0.1580	21.36	9.70	31.06	55.56	-24.50	AVG	
3	0.1780	32.73	9.71	42.44	64.57	-22.13	QP	
4	0.2860	22.59	9.72	32.31	60.64	-28.33	QP	
5	0.2940	12.09	9.72	21.81	50.41	-28.60	AVG	
6	0.5260	15.76	9.76	25.52	46.00	-20.48	AVG	
7	0.5299	24.00	9.76	33.76	56.00	-22.24	QP	
8	0.8860	6.37	9.74	16.11	46.00	-29.89	AVG	
9	0.8900	14.74	9.74	24.48	56.00	-31.52	QP	
10	15.3100	24.47	10.00	34.47	60.00	-25.53	QP	
11	15.3100	18.10	10.00	28.10	50.00	-21.90	AVG	
12	18.1820	8.49	10.07	18.56	50.00	-31.44	AVG	



### Conducted Emission Test Data

Test Site: 1# Shielded Room  
 Operating Condition: High CH (927.25MHz)  
 Test Specification: DC 5V from Debug board input AC 120V, 60Hz for Adapter  
 Comment: Neutral Line  
 Temp.(°C)/Hum.(%RH): 23.9°C/45%RH



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB)	Result (dBuV)	Limit (dBuV)	Over Limit (dB)	Detector	Remark
1	0.1539	36.07	9.70	45.77	65.78	-20.01	QP	
2	0.1539	24.54	9.70	34.24	55.78	-21.54	AVG	
3	0.1740	23.27	9.71	32.98	54.76	-21.78	AVG	
4	0.4060	22.49	9.71	32.20	57.73	-25.53	QP	
5	0.5299	26.06	9.76	35.82	56.00	-20.18	QP	
6	0.5380	18.66	9.76	28.42	46.00	-17.58	AVG	
7	0.9180	6.42	9.74	16.16	46.00	-29.84	AVG	
8	1.2460	16.99	9.73	26.72	56.00	-29.28	QP	
9	14.4420	26.72	9.97	36.69	60.00	-23.31	QP	
10	15.3220	19.67	10.00	29.67	50.00	-20.33	AVG	
11	16.7620	18.36	10.04	28.40	60.00	-31.60	QP	
12	18.1980	9.90	10.07	19.97	50.00	-30.03	AVG	



## 4. Radiation Spurious Emission and Band Edge

### 4.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.209 and 15.205				
Test Limit	Frequency (MHz)	Field strength (microvolt/meter)	Limit (dBuV/m)	Remark	Measurement distance (m)
	0.009MHz~0.490MHz	2400/F(kHz)	-	-	300
	0.490MHz~1.705MHz	24000/F(kHz)	-	-	30
	1.705MHz~30MHz	30	-	-	30
	30MHz~88MHz	100	40.0	Quasi-peak	3
	88MHz~216MHz	150	43.5	Quasi-peak	3
	216MHz~960MHz	200	46.0	Quasi-peak	3
	960MHz~1000MHz	500	54.0	Quasi-peak	3
	Above 1000MHz		500	54.0	Average
		-	74.0	Peak	3

**Remark:**

(1)The lower limit shall apply at the transition frequency.

(2) 15.35(b), Unless otherwise specified, the limit on peak radio frequency emissions is 20dB above the maximum permitted average emission limit applicable to the equipment under test. This peak limit applies to the total peak emission level radiated by the device.

### 4.2. Test Setup

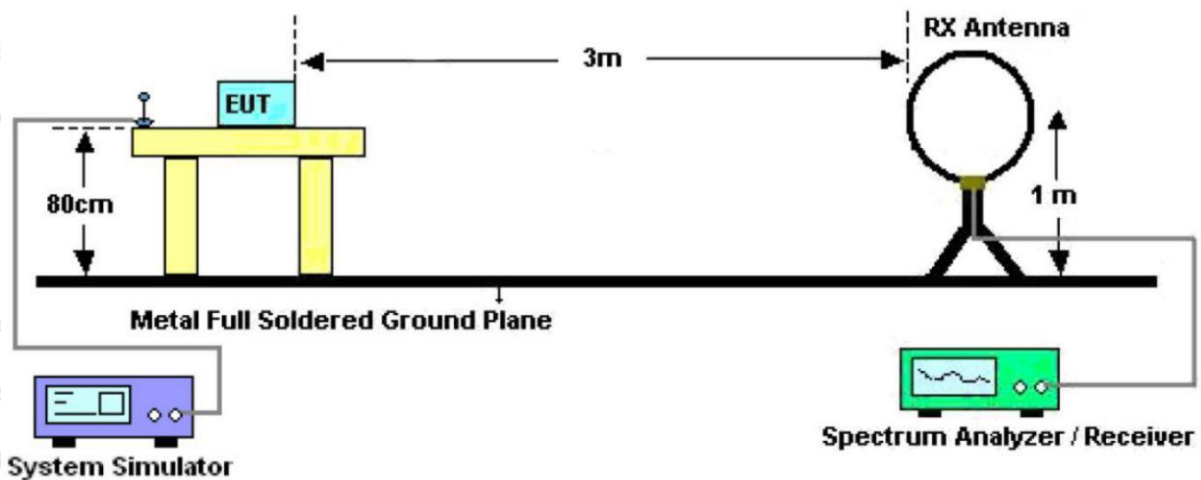


Figure 1. Below 30MHz



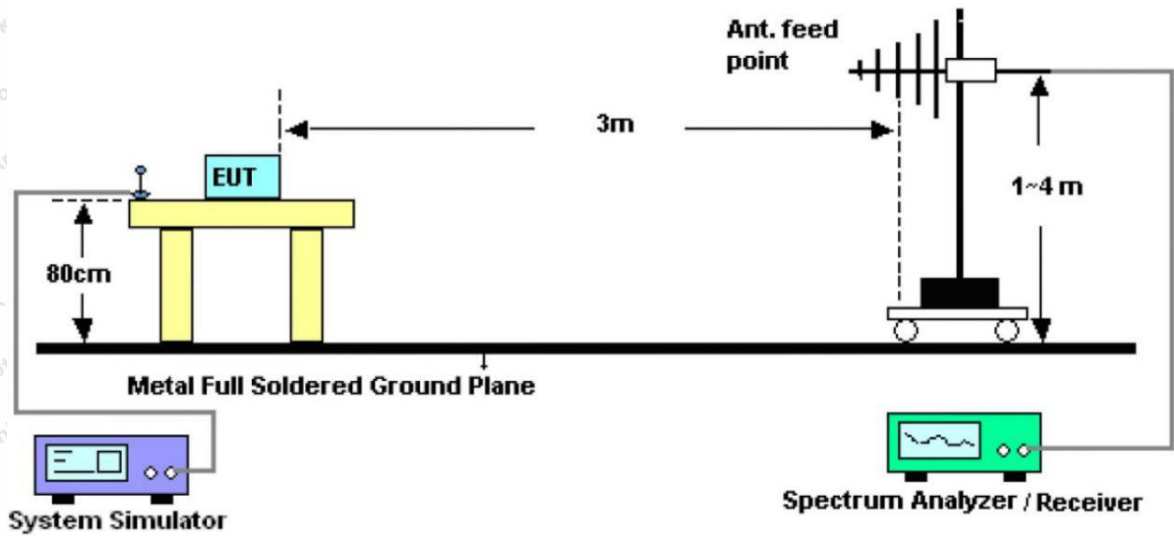


Figure 2. 30MHz to 1GHz

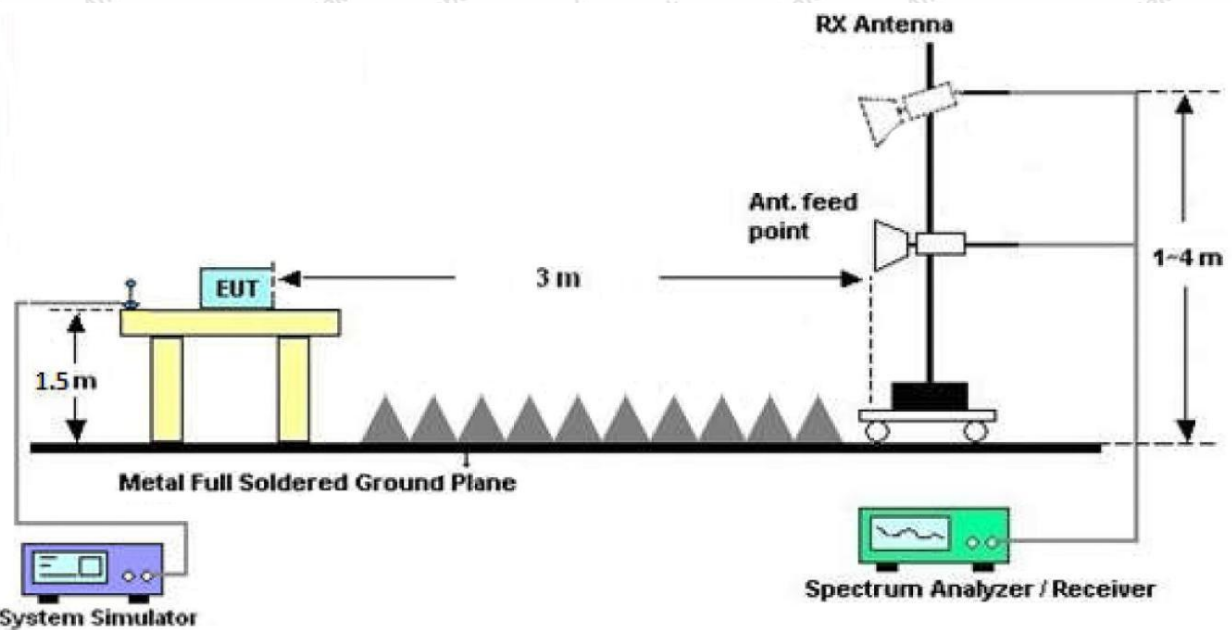


Figure 3. Above 1 GHz

### 4.3. Test Procedure

For below 1GHz: The EUT is placed on a turntable, which is 0.8m above the ground plane.

For above 1GHz: The EUT is placed on a turntable, which is 1.5m above the ground plane.

The turn table can rotate 360 degrees to determine the position of the maximum emission level. The EUT is set 3 meters away from the receiving antenna which is mounted on a antenna tower. The antenna can be moved up and down from 1 to 4 meters to find out the maximum emission level. Rotated the EUT through three orthogonal axes to determine the maximum emissions, both horizontal and vertical polarization of the antenna are set on test. The EUT is tested in 9\*6\*6 Chamber. The device is evaluated in xyz orientation.





For the radiated emission test above 1GHz:

Place the measurement antenna away from each area of the EUT determined to be a source of emissions at the specified measurement distance, while keeping the measurement antenna aimed at the source of emissions at each frequency of significant emissions, with polarization oriented for maximum response. The measurement antenna may have to be higher or lower than the EUT, depending on the radiation pattern of the emission and staying aimed at the emission source for receiving the maximum signal. The final measurement antenna elevation shall be that which maximizes the emissions. The measurement antenna elevation for maximum emissions shall be restricted to a range of heights of from 1 m to 4 m above the ground or reference ground plane.

For 9kHz to 150kHz, Set the spectrum analyzer as:

RBW = 200Hz, VBW =1kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 150kHz to 30MHz, Set the spectrum analyzer as:

RBW = 9KHz, VBW =30kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For 30MHz to 1000MHz, Set the spectrum analyzer as:

RBW = 100kHz, VBW =300kHz, Detector= Quasi-Peak, Trace mode= Max hold, Sweep- auto couple.

For above 1GHz, Set the spectrum analyzer as:

RBW =1MHz, VBW =1MHz, Detector= Peak, Trace mode= Max hold, Sweep- auto couple.

RBW =1MHz, VBW =10Hz, Detector= Average, Trace mode= Max hold, Sweep- auto couple.

#### 4.4. Test Data

##### PASS

During the test, Pre-scan all kind of the place mode (X-axis, Y-axis, Z-axis), and found the X-axis is the worst case.

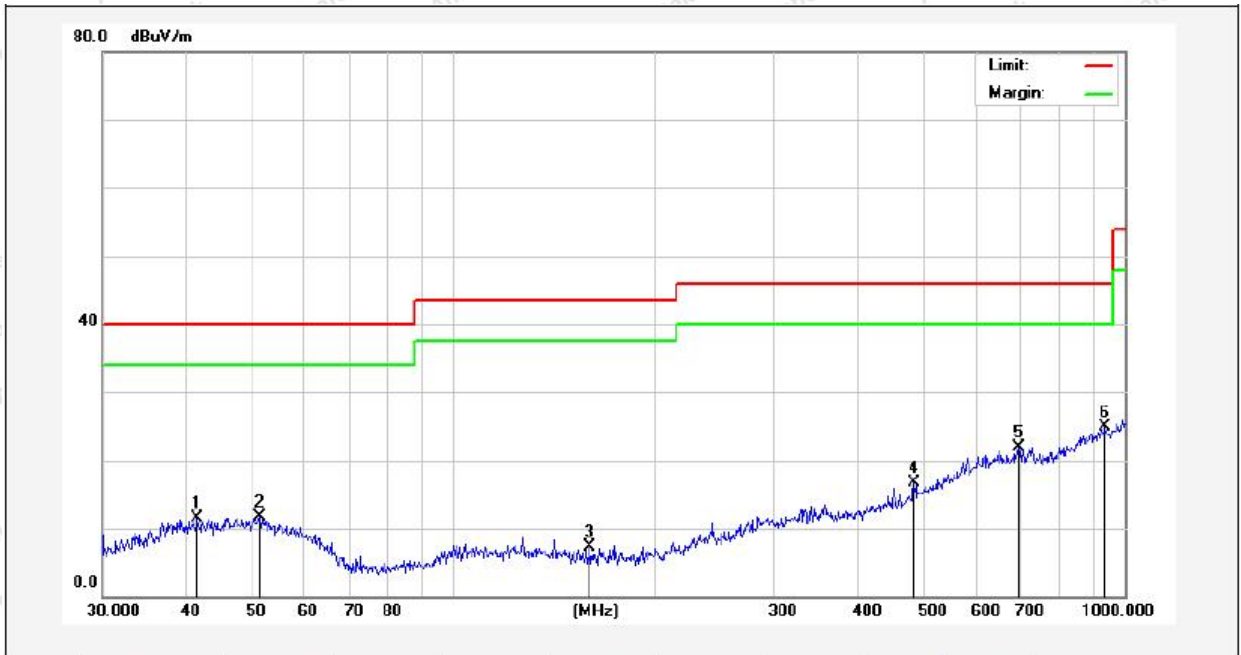
The test results of 9kHz-30MHz was attenuated more than 20dB below the permissible limits, so the results don't record in the report.

During the test, pre-scan all modes, only the worst case is recorded in the report.



**Test Results (30~1000MHz)**

Test Mode: High CH (927.25MHz)  
 Power Source: DC 5V from Debug board input AC 120V, 60Hz for Adapter  
 Polarization: Horizontal  
 Temp.(°C)/Hum.(%RH): 23.6°C/47%RH

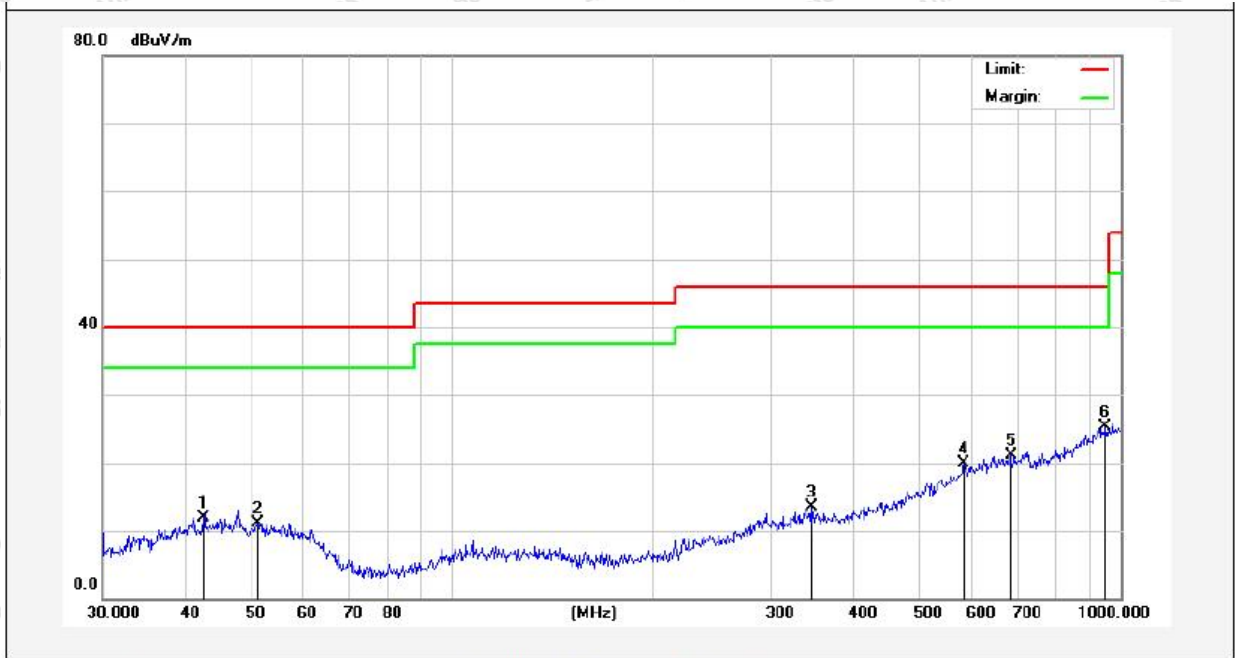


No.	Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	41.5670	27.32	-15.77	11.55	40.00	-28.45	QP			
2	51.4807	27.94	-16.32	11.62	40.00	-28.38	QP			
3	159.7844	31.37	-24.00	7.37	43.50	-36.13	QP			
4	485.6093	30.86	-14.25	16.61	46.00	-29.39	QP			
5	694.4174	31.90	-10.00	21.90	46.00	-24.10	QP			
6	935.5463	30.77	-5.81	24.96	46.00	-21.04	QP			



**Test Results (30~1000MHz)**

Test Mode: High CH (927.25MHz)  
 Power Source: DC 5V from Debug board input AC 120V, 60Hz for Adapter  
 Polarization: Vertical  
 Temp.(°C)/Hum.(%RH): 23.6°C/47%RH



No.	Freq. (MHz)	Reading (dBuV)	Factor (dB/m)	Result (dBuV/m)	Limit (dBuV/m)	Over Limit (dB)	Detector	Height (cm)	degree (deg)	Remark
1	42.4508	26.72	-14.81	11.91	40.00	-28.09	QP			
2	51.3005	27.40	-16.25	11.15	40.00	-28.85	QP			
3	344.3855	28.66	-15.14	13.52	46.00	-32.48	QP			
4	582.7425	30.87	-10.95	19.92	46.00	-26.08	QP			
5	684.7454	31.22	-10.14	21.08	46.00	-24.92	QP			
6	948.7610	30.92	-5.65	25.27	46.00	-20.73	QP			



**Test Results (1GHz-25GHz)**

Test channel: Lowest									
Frequency (MHz)	Antenna Pol.	Reading (dBuV/m)	Cable Loss (dB)	Ant Factor (dB)	Amplifier (dB)	Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)	Det. Mode
1805.5000	H	43.53	7.39	28.73	26.31	53.34	74	-20.66	PK
1805.5000	H	34.92	7.39	28.73	26.31	44.73	54	-9.27	AV
2708.2500	H	42.02	8.10	29.71	27.01	52.82	74	-21.18	PK
2708.2500	H	33.96	8.10	29.71	27.01	44.76	54	-9.24	AV
3611.0000	H	*							PK
3611.0000	H	*							AV
1805.5000	V	42.28	7.39	28.73	26.31	52.09	74	-21.91	PK
1805.5000	V	34.82	7.39	28.73	26.31	44.63	54	-9.37	AV
2708.2500	V	41.40	8.10	29.71	27.01	52.20	74	-21.80	PK
2708.2500	V	33.68	8.10	29.71	27.01	44.48	54	-9.52	AV
3611.0000	V	*							PK
3611.0000	V	*							AV

Test channel: Middle									
Frequency (MHz)	Antenna Pol.	Reading (dBuV/m)	Cable Loss (dB)	Ant Factor (dB)	Amplifier (dB)	Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)	Det. Mode
1830.5000	H	46.49	7.41	28.72	26.31	56.31	74	-17.69	PK
1830.5000	H	35.48	7.41	28.72	26.31	45.30	54	-8.70	AV
2745.7500	H	46.04	8.11	29.71	27.01	56.85	74	-17.15	PK
2745.7500	H	36.15	8.11	29.71	27.01	46.96	54	-7.04	AV
3661.0000	H	*							PK
3661.0000	H	*							AV
1830.5000	V	47.36	7.41	28.72	26.31	57.18	74	-16.82	PK
1830.5000	V	36.70	7.41	28.72	26.31	46.52	54	-7.48	AV
2745.7500	V	46.86	8.11	29.71	27.01	57.67	74	-16.33	PK
2745.7500	V	36.06	8.11	29.71	27.01	46.87	54	-7.13	AV
3661.0000	V	*							PK
3661.0000	V	*							AV



Test channel: High									
Frequency (MHz)	Antenna Pol.	Reading (dBuV/m)	Cable Loss (dB)	Ant Factor (dB)	Amplifier (dB)	Level (dBuV/m)	Limits (dBuV/m)	Margin (dB)	Det. Mode
1854.5000	H	46.85	7.43	28.69	26.31	56.66	74	-17.34	PK
1854.5000	H	36.52	7.43	28.69	26.31	46.33	54	-7.67	AV
2781.7500	H	45.31	8.15	29.84	27.01	56.29	74	-17.71	PK
2781.7500	H	34.90	8.15	29.84	27.01	45.88	54	-8.12	AV
3709.0000	H	*							PK
3709.0000	H	*							AV
1854.5000	V	48.02	7.43	28.69	26.31	57.83	74	-16.17	PK
1854.5000	V	36.67	7.43	28.69	26.31	46.48	54	-7.52	AV
2781.7500	V	46.59	8.15	29.84	27.01	57.57	74	-16.43	PK
2781.7500	V	34.32	8.15	29.84	27.01	45.30	54	-8.70	AV
3709.0000	V	*							PK
3709.0000	V	*							AV

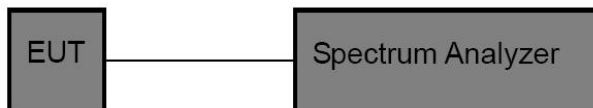


## 5. Maximum Peak Output Power Test

### 5.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (b)(2)
Test Limit	For frequency hopping systems operating in the 902-928 MHz band: 1 watt for systems employing at least 50 hopping channels; and, 0.25 watts for systems employing less than 50 hopping channels, but at least 25 hopping channels, as permitted under paragraph (a)(1)(i) of this section.

### 5.2. Test Setup



### 5.3. Test Procedure

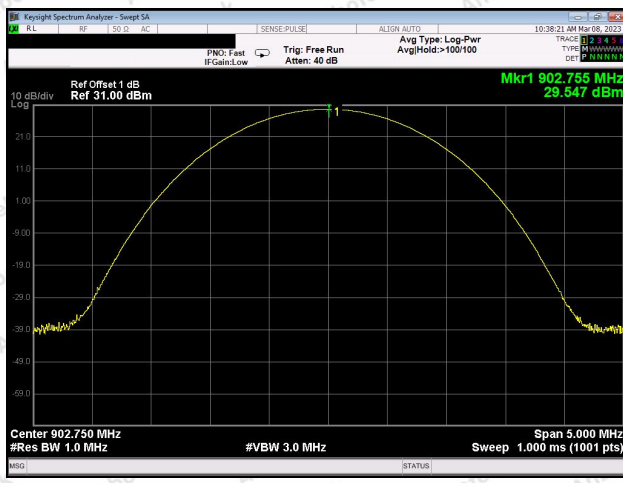
- The EUT was directly connected to the spectrum analyzer and antenna output port as show in the block diagram above,
- Spectrum Setting:
  - RBW > the 20 dB bandwidth of the emission being measured
  - Span = approximately 5 times the 20 dB bandwidth, centered on a hopping channel
  - VBW ≥ RBW
  - Sweep = auto
  - Detector function = peak
  - Trace = max hold

### 5.4. Test Data

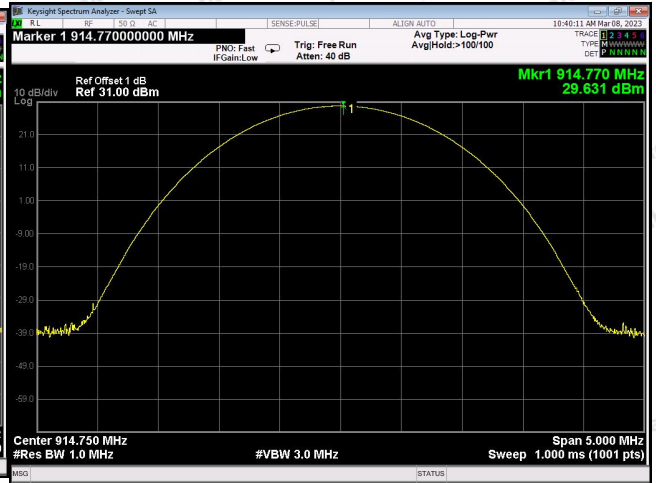
Test Item	:	Max. peak output power	Test Mode	:	CH Low ~ CH High
Test Voltage	:	DC 5V from Debug board input AC 120V, 60Hz for Adapter	Temperature	:	23.6° C
Test Result	:	PASS	Humidity	:	49 %

Test Channel	Peak Power output (dBm)	Limit (dBm)	Results
Low	29.547	30.00	PASS
Middle	29.631	30.00	PASS
High	29.591	30.00	PASS

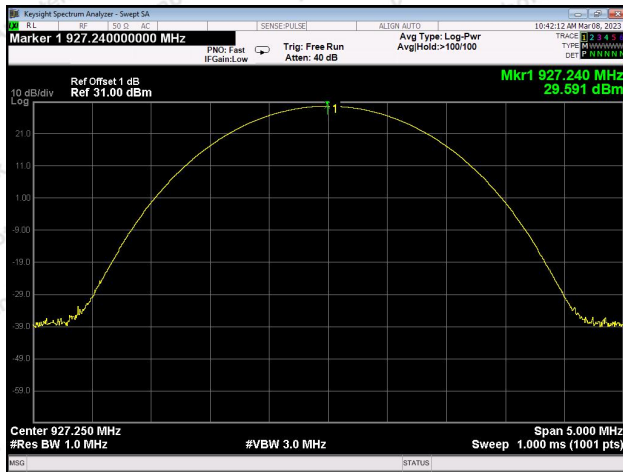




Low Channel



Mid Channel



High Channel

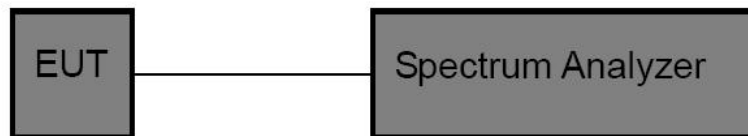


## 6. 20DB Occupy Bandwidth Test

### 6.1. Test Standard

Test Standard	FCC Part15 C Section 15.247 (a)(1)(i)
Limit	Less than 250KHz

### 6.2. Test Setup



### 6.3. Test Procedure

Using the following spectrum analyzer settings:

1. Span= approximately 2 to 3 times the 20dB bandwidth, centered on a hopping channel.
2. Set the RBW  $\geq 1\%$  of the 20 dB bandwidth.
3. Set the VBW  $\geq$  RBW.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

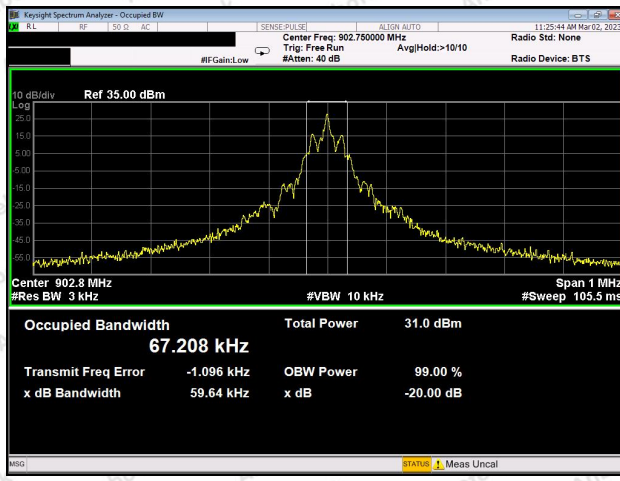
### 6.4. Test Data

Test Item	: 20dB BW	Test Mode	: CH Low ~ CH High
Test Voltage	: DC 5V from Debug board input AC 120V, 60Hz for Adapter	Temperature	: 23.6°C
Test Result	: PASS	Humidity	: 53 %

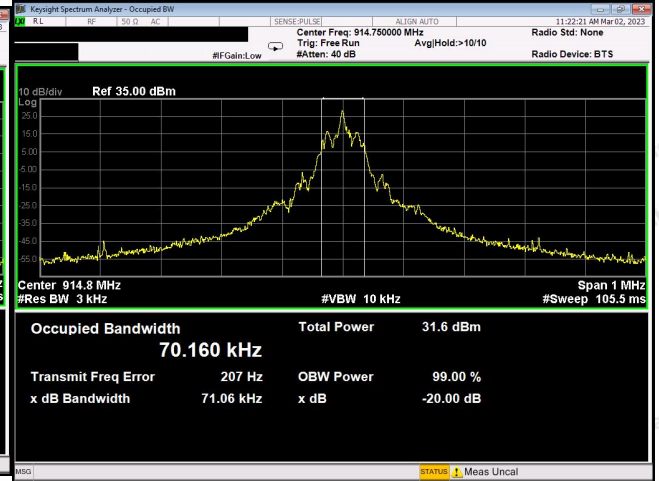
Test Channel	Bandwidth (kHz)	Limit (kHz)	Results
Low	59.64	$\leq 250$	PASS
Middle	71.06	$\leq 250$	PASS
High	70.34	$\leq 250$	PASS



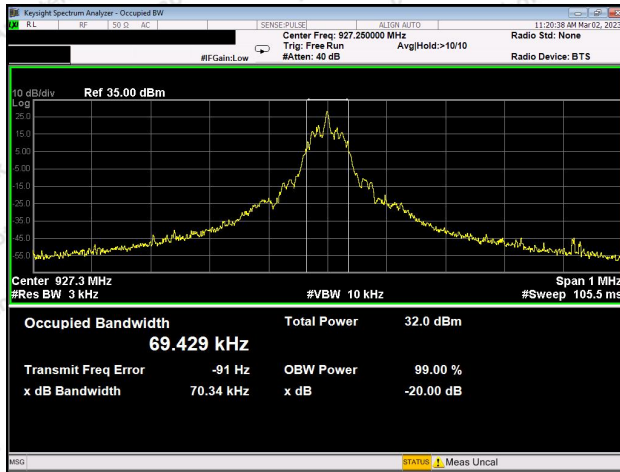




Low Channel



Mid Channel



High Channel

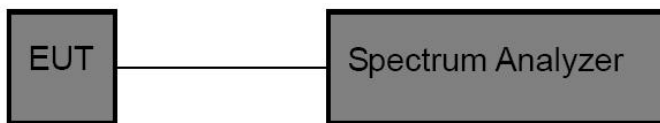


## 7. Carrier Frequency Separation Test

### 7.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (a)(1)
Test Limit	> 25 kHz or the 20 dB bandwidth whichever is greater.

### 7.2. Test Setup



### 7.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer settings:

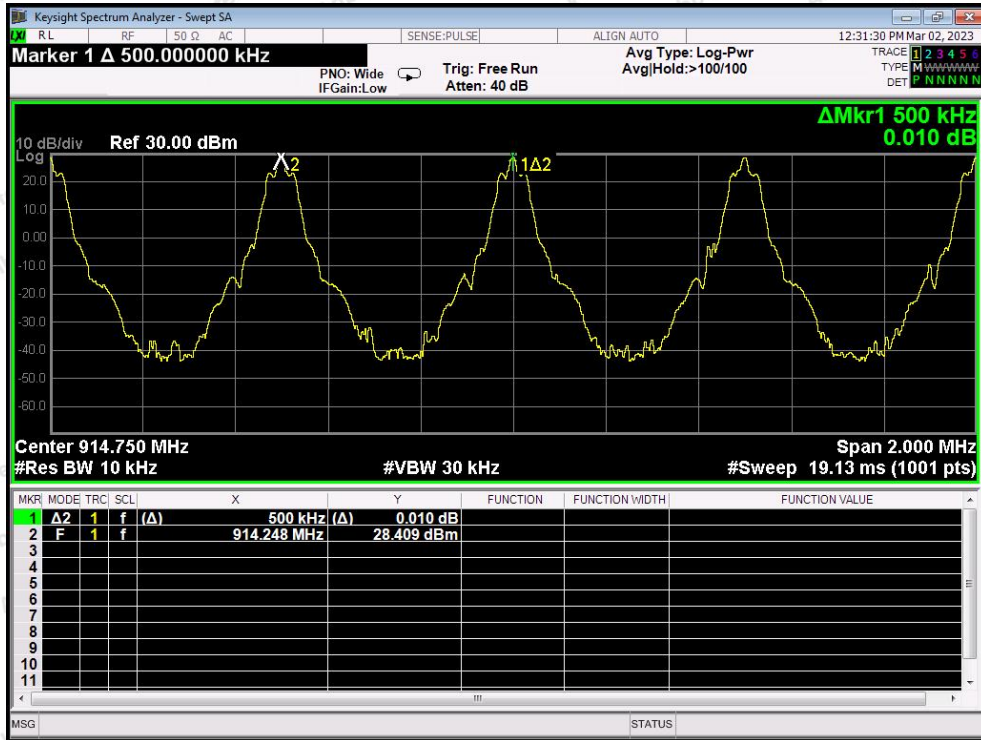
1. Span= Wide enough to capture the peaks of two adjacent channels
2. Set the RBW =approximately 30% of the channel spacing.
3. Set the VBW  $\geq$  RBW.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

### 7.4. 7.4. Test Data

Test Item	:	Frequency Separation	Test Mode	:	Hopping
Test Voltage	:	DC 5V from Debug board input AC 120V, 60Hz for Adapter	Temperature	:	23.6°C
Test Result	:	PASS	Humidity	:	49 %

Mode	Frequency (MHz)	Separation Read Value (kHz)	Limit (kHz)	Result
Hopping	914.75	500	71.06	PASS





Hopping

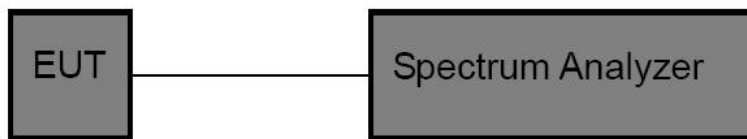


## 8. Number of Hopping Channel Test

### 8.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247(a)(1)(i)
Test Limit	$\geq 50$ channels for 20 dB bandwidth less than 250KHz $\geq 25$ channels for 20 dB bandwidth greater than 250KHz

### 8.2. Test Setup



### 8.3. Test Procedure

The EUT must have its hopping function enabled. Using the following spectrum analyzer setting:

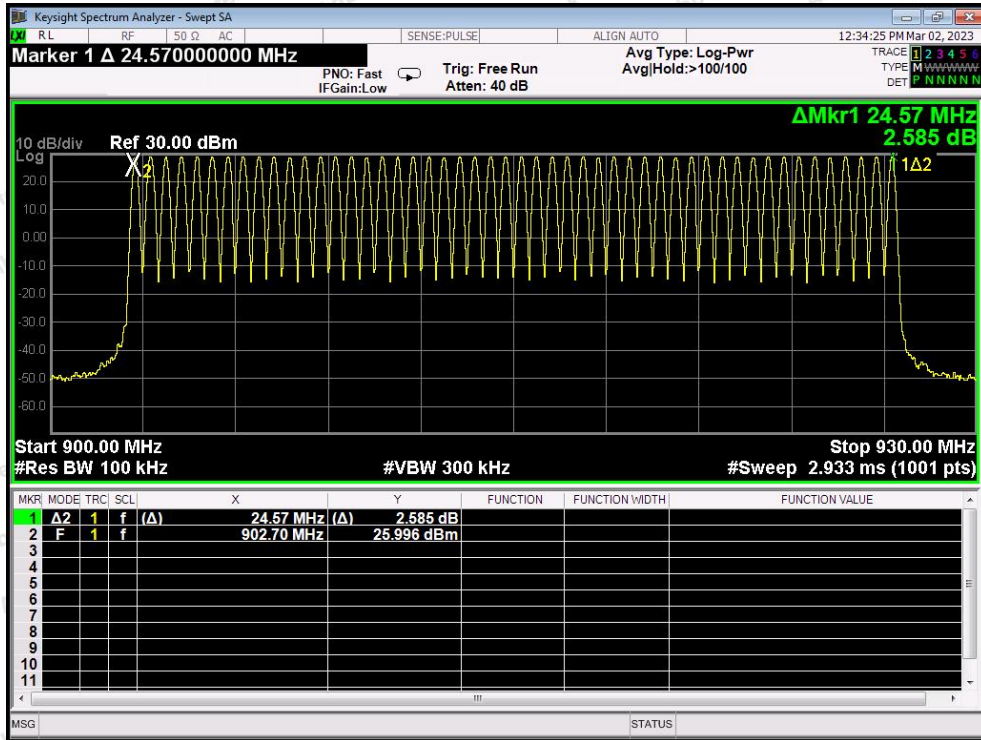
1. Span= the frequency band of operation
2. Set the RBW = less than 30% of the channel spacing or the 20 dB bandwidth, whichever is smaller.
3. Set the VBW  $\geq$  RBW.
4. Sweep time = auto couple.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

### 8.4. Test Data

Test Item	:	Number of Hopping Frequency	Test Mode	:	Hopping
Test Voltage	:	DC 5V from Debug board input AC 120V, 60Hz for Adapter	Temperature	:	23.6° C
Test Result	:	PASS	Humidity	:	49 %

Hopping Channel Frequency Range	Quantity of Hopping Channel	Quantity of Hopping Channel
902-928MHz	50	$\geq 50$





Hopping

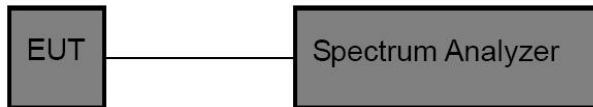


## 9. Dwell Time Test

### 9.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247(a)(1)(i), 15.247(f)
Test Limit	<p>15.247(a)(1)(i): if the 20 dB bandwidth of the hopping channel is less than 250 KHz, the system shall use at least 50 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 20 second period; if the 20 dB bandwidth of the hopping channel is 250 KHz or greater, the system shall use at least 25 hopping frequencies and the average time of occupancy on any frequency shall not be greater than 0.4 seconds within a 10 second period.</p> <p>15.247(f): For the purposes of this section, hybrid systems are those that employ a combination of both frequency hopping and digital modulation techniques. The frequency hopping operation of the hybrid system, with the direct sequence or digital modulation operation turned-off, shall have an average time of occupancy on any frequency not to exceed 0.4 seconds within a time period in seconds equal to the number of hopping frequencies employed multiplied by 0.4</p>

### 9.2. Test Setup



### 9.3. Test Procedure

The EUT must have its hopping function enabled. Use the following spectrum analyzer settings:

1. Span= zero span, centered on a hopping channel
2. Set the RBW = 100 KHz.
3. Set the VBW = 300 KHz.
4. Sweep time = as necessary to capture the entire dwell time per hopping channel.
5. Detector function = peak.
6. Trace mode = max hold.
7. Allow trace to fully stabilize.

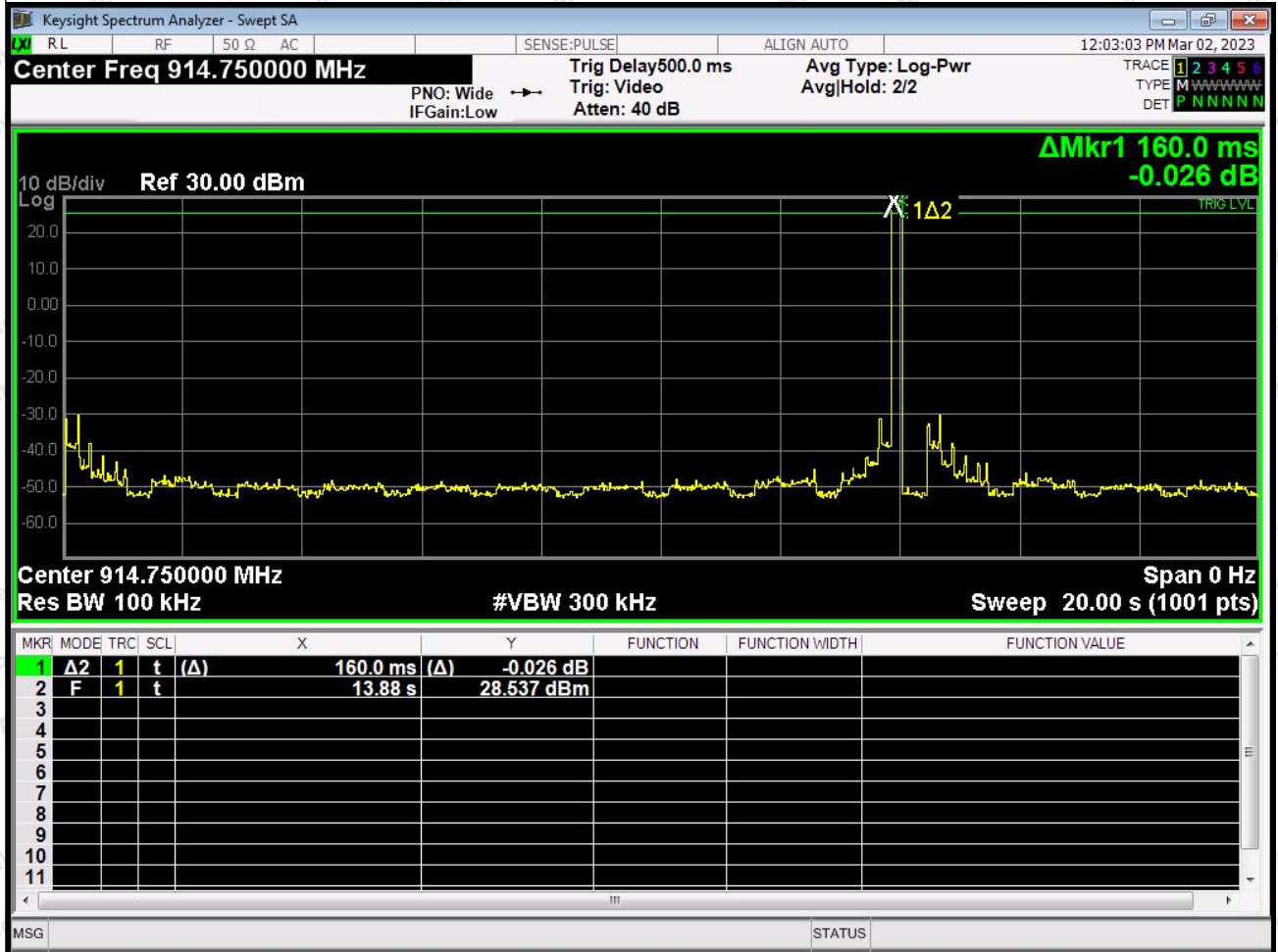
### 9.4. Test Data

Test Item	:	Time of Occupancy	Test Mode	:	Hopping
Test Voltage	:	DC 5V from Debug board input AC 120V, 60Hz for Adapter	Temperature	:	23.6° C



Test Result	:	PASS	Humidity	:	49 %
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Requirement	Pulse width (ms)	Observe Period(s)	Dwell time (ms)	Limit (s)	Result
15.247(a)(1)(i)	160.00	20.00	160.00	0.40	PASS



Hopping

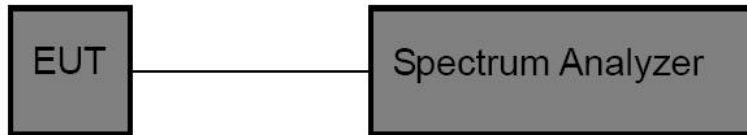


## 10. 100kHz Bandwidth of Frequency Band Edge Requirement

### 10.1. Test Standard and Limit

Test Standard	FCC Part15 C Section 15.247 (d)
Test Limit	in any 100 kHz bandwidth outside the frequency bands in which the spread spectrum intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a), must also comply with the radiated emission limits specified in 15.209(a).

### 10.2. Test Setup



### 10.3. Test Procedure

The EUT must have its hopping/Non-hopping function enabled. Using the following spectrum analyzer setting:

1. Set the RBW = 100kHz.
2. Set the VBW = 300kHz.
3. Sweep time = auto couple.
4. Detector function = peak.
5. Trace mode = max hold.
6. Allow trace to fully stabilize.

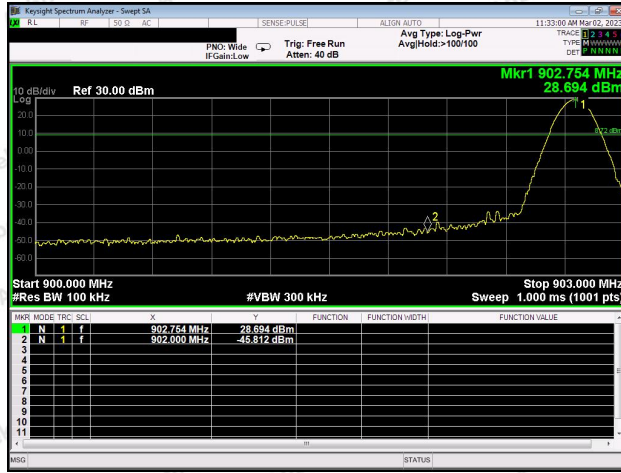
### 10.4. Test Data

Test Item	:	Band edge	Test Mode	:	CH Low, CH High
Test Voltage	:	DC 5V from Debug board input AC 120V, 60Hz for Adapter	Temperature	:	23.6° C
Test Result	:	PASS	Humidity	:	49 %

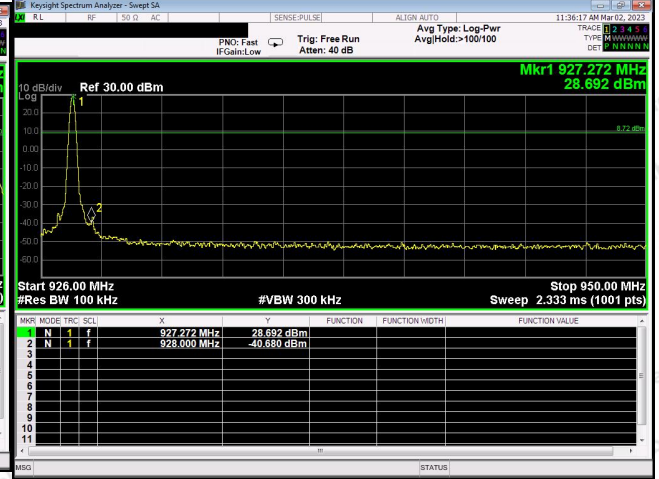




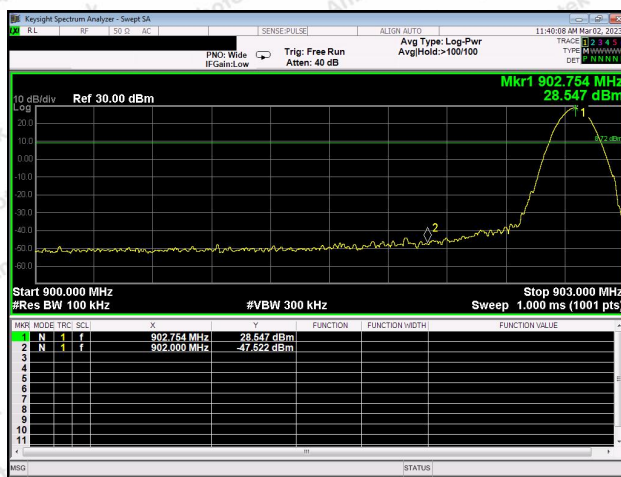
## Band edge measurements



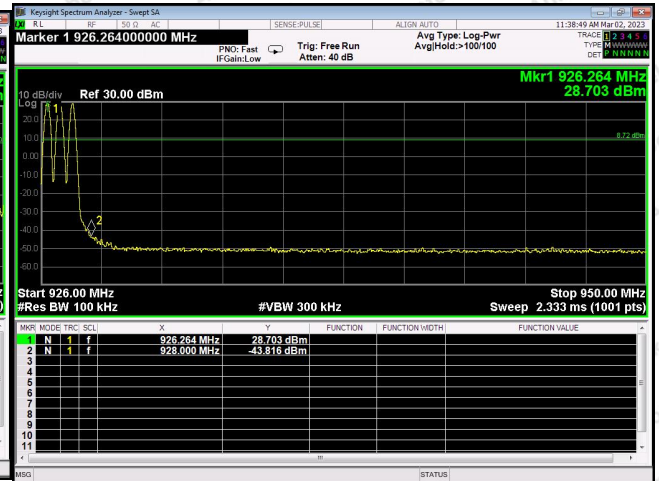
For Low channel Non-Hopping Mode



For High channel Non-Hopping Mode



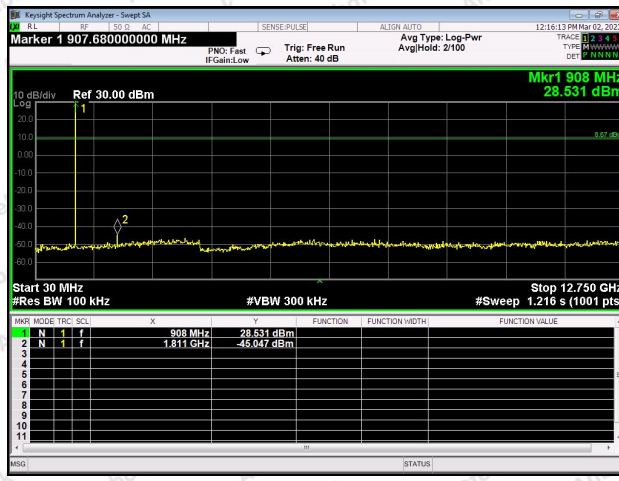
For Low channel Hopping Mode



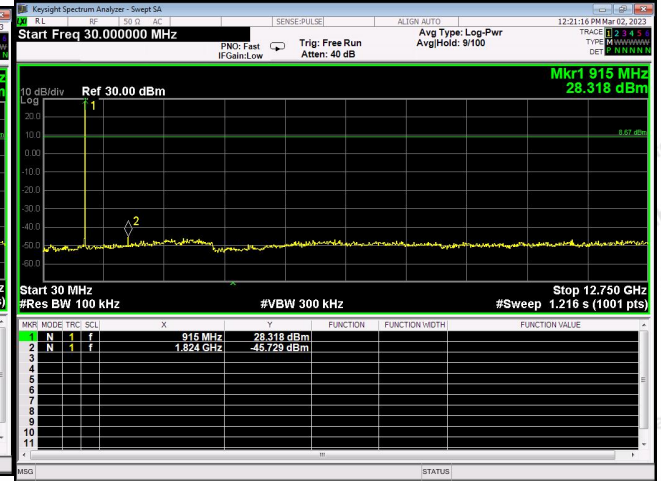
For High channel Hopping Mode



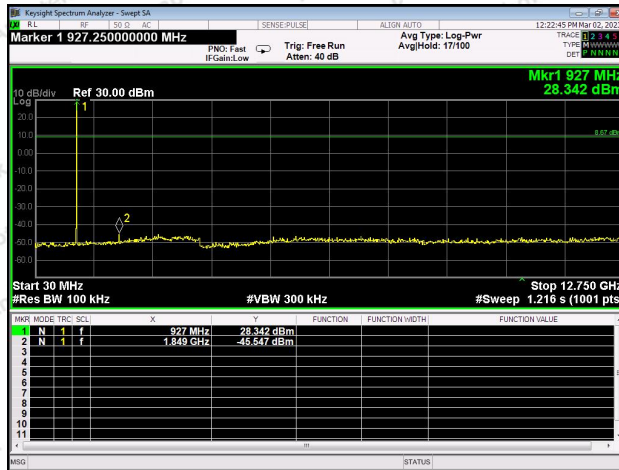
### Conducted Emission Method



Low Channel



Mid Channel



High Channel



## 11. Antenna Requirement

### 11.1. Test Standard and Requirement

Test Standard	FCC Part15 Section 15.203 /247(c)
Requirement	<p>1) 15.203 requirement: An intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device. The use of a permanently attached antenna or of an antenna that uses a unique coupling to the intentional radiator, the manufacturer may design the unit so that a broken antenna can be replaced by the user, but the use of a standard antenna jack or electrical connector is prohibited.</p> <p>2) 15.247(c) (1)(i) requirement: Systems operating in the 2400-2483.5 MHz band that is used exclusively for fixed. Point-to-point operations may employ transmitting antennas with directional gain greater than 6dBi provided the maximum conducted output power of the intentional radiator is reduced by 1 dB for every 3 dB that the directional gain of the antenna exceeds 6 dBi.</p>

### 11.2. Antenna Connected Construction

The antenna is Ceramic antenna which permanently attached, and the best case gain of the antenna is 2.5dBi. It complies with the standard requirement.



## APPENDIX I -- TEST SETUP PHOTOGRAPH

Please refer to separated files Appendix I -- Test Setup Photograph

## APPENDIX II -- EXTERNAL PHOTOGRAPH

Please refer to separated files Appendix II -- External Photograph

## APPENDIX III -- INTERNAL PHOTOGRAPH

Please refer to separated files Appendix III -- Internal Photograph

----- End of Report -----

